

Search Notes

Application/Control No.

10/760,505

Examiner

Lois Zheng

Applicant(s)/Patent under
Reexamination

HIRAIWA ET AL.

Art Unit

1742

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 204 | 242 | 2/9/2007 | LLZ |
| 204 | 243.1 | 2/9/2007 | LLZ |
| 204 | 274 | 2/9/2007 | LLZ |
| 205 | 355-356 | 2/9/2007 | LLZ |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---------------------|----------|------|
| inventorship search | 2/9/2007 | LLZ |
| Updated EAST search | 2/9/2007 | LLZ |
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